

Notice of References Cited	Application/Control No. 10/778,006		Applicant(s)/Patent Under Reexamination BRUCE ET AL.	
	Examiner Charles A. Marmor, II		Art Unit 3736	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0231686 A1	10-2005	Rathjen, Christian	351/205
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	den Besten et al, "A New Tonometer Based on the Application of Micro-Mechanical Sensors", IEEE (1993), 0-7803-0957-2/93, pages 105-110.
	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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